Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10576819	FUKUCHI ET AL.
Examiner	Art Unit
Wai-Sing Louie	2814

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
TFT, LCD, gate insulation, semiconductor active layer, source/ drain wiring, mobility, hydrogen content	1/13/09	WSL

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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